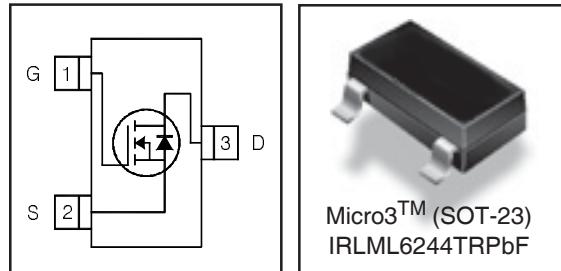


IRLML6244TRPbF

HEXFET® Power MOSFET

V_{DS}	20	V
V_{GS Max}	±12	V
R_{DS(on)} max (@V_{GS} = 4.5V)	21.0	mΩ
R_{DS(on)} max (@V_{GS} = 2.5V)	27.0	mΩ



Application(s)

- Load/ System Switch

Features and Benefits

Features

Low R _{DS(on)} (< 21mΩ)
Industry-standard SOT-23 Package
RoHS compliant containing no lead, no bromide and no halogen

Benefits

Lower conduction losses
Multi-vendor compatibility
Environmentally friendly

results in ⇒

Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
V _{DS}	Drain-Source Voltage	20	V
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V	6.3	A
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V	5.1	
I _{DM}	Pulsed Drain Current	32	W
P _D @ T _A = 25°C	Maximum Power Dissipation	1.3	
P _D @ T _A = 70°C	Maximum Power Dissipation	0.80	W/°C
	Linear Derating Factor	0.01	
V _{GS}	Gate-to-Source Voltage	± 12	V
T _J , T _{STG}	Junction and Storage Temperature Range	-55 to + 150	°C

Thermal Resistance

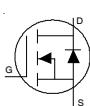
Symbol	Parameter	Typ.	Max.	Units
R _{θJA}	Junction-to-Ambient ③	—	100	°C/W
R _{θJA}	Junction-to-Ambient (t<10s) ④	—	99	

IRML6244TRPbF

Electric Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	20	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	7.8	—	mV/ $^\circ\text{C}$	Reference to 25°C , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	16.0	21.0	m Ω	$V_{\text{GS}} = 4.5\text{V}$, $I_D = 6.3\text{A}$ ②
		—	22.0	27.0		$V_{\text{GS}} = 2.5\text{V}$, $I_D = 5.1\text{A}$ ②
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	0.5	0.9	1.1	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = 10\mu\text{A}$
I_{DSS}	Drain-to-Source Leakage Current	—	—	1.0	μA	$V_{\text{DS}} = 16\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	150		$V_{\text{DS}} = 16\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}} = 12\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}} = -12\text{V}$
R_G	Internal Gate Resistance	—	1.7	—	Ω	
g_{fs}	Forward Transconductance	17	—	—	S	$V_{\text{DS}} = 10\text{V}$, $I_D = 6.3\text{A}$
Q_g	Total Gate Charge	—	8.9	—	nC	$I_D = 6.3\text{A}$
Q_{gs}	Gate-to-Source Charge	—	0.68	—		$V_{\text{DS}} = 10\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	4.4	—		$V_{\text{GS}} = 4.5\text{V}$ ②
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	4.9	—	ns	$V_{\text{DD}} = 10\text{V}$ ②
t_r	Rise Time	—	7.5	—		$I_D = 1.0\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	19	—		$R_G = 6.8\Omega$
t_f	Fall Time	—	12	—		$V_{\text{GS}} = 4.5\text{V}$
C_{iss}	Input Capacitance	—	700	—	pF	$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance	—	140	—		$V_{\text{DS}} = 16\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	98	—		$f = 1.0\text{MHz}$

Source - Drain Ratings and Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	1.3	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ①	—	—	32		
V_{SD}	Diode Forward Voltage	—	—	1.2	V	$T_J = 25^\circ\text{C}$, $I_S = 6.3\text{A}$, $V_{\text{GS}} = 0\text{V}$ ②
t_{rr}	Reverse Recovery Time	—	12	18	ns	$T_J = 25^\circ\text{C}$, $V_R = 15\text{V}$, $I_F = 1.3\text{A}$
Q_{rr}	Reverse Recovery Charge	—	5.1	7.7	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ②